



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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企业微信二维码



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Product Summary

$V_{(BR)DSS}$	$R_{DS(on)}$	I_D $T_A = +25^\circ\text{C}$
-100V	350m Ω @ $V_{GS} = -10\text{V}$	-1.6A
	450m Ω @ $V_{GS} = -6\text{V}$	-1.4A

Description

This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

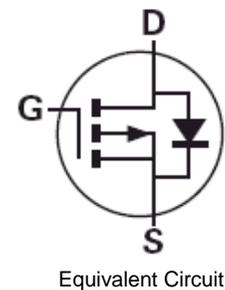
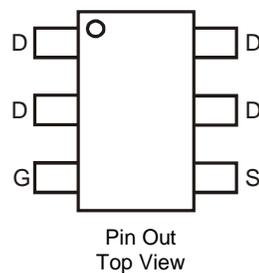
- Motor Control
- DC-DC Converters
- Power Management Functions
- Uninterrupted Power Supply

Features and Benefits

- Fast Switching Speed
- Low Gate Drive
- Low Input Capacitance

Mechanical Data

- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram Below
- Terminals: Finish - Matte Tin Annealed over Copper Leadframe; Solderable per MIL-STD-202, Method 208 ^(e3)
- Weight: 0.018 grams (Approximate)



Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic			Symbol	Value	Unit	
Drain-Source Voltage			V_{DSS}	-100	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	$V_{GS} = 10\text{V}$	(Note 6)	I_D	-1.6	A	
		$T_A = +70^\circ\text{C}$ (Note 6)		-1.3		
		(Note 5)		-1.3		
Pulsed Drain Current	$V_{GS} = 10\text{V}$	(Note 7)	I_{DM}	-7.7	A	
Continuous Source Current (Body Diode)			(Note 6)	I_S	-2.1	A
Pulsed Source Current (Body Diode)			(Note 7)	I_{SM}	-7.7	A

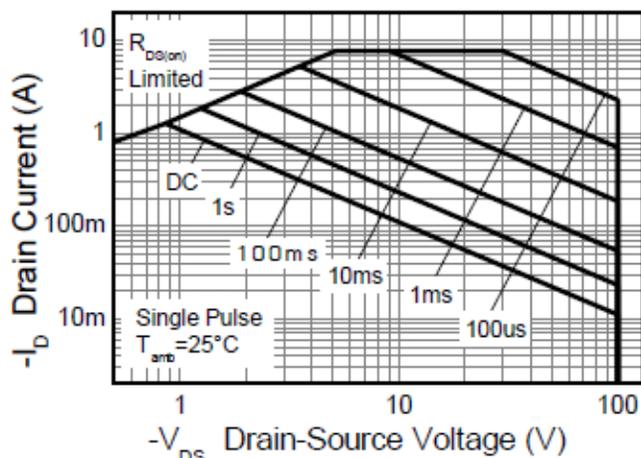
Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Power Dissipation	(Note 5)	P_D	1.1	W
	(Note 6)		8.8	
Linear Derating Factor			1.7	$\text{mW}/^\circ\text{C}$
Thermal Resistance, Junction to Ambient	(Note 5)	$R_{\theta JA}$	113	$^\circ\text{C}/\text{W}$
	(Note 6)		73	
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

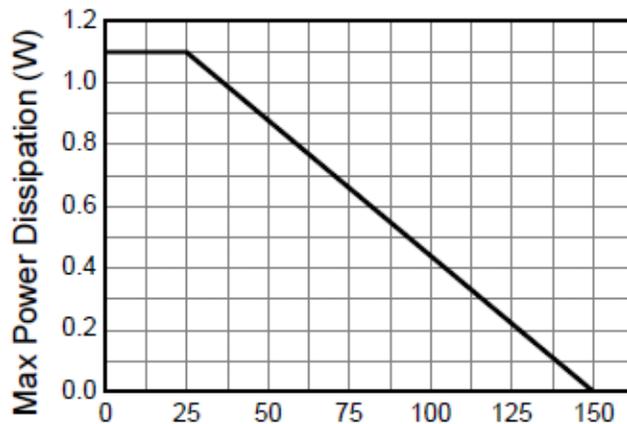
Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	-100	—	—	V	$I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-0.5	μA	$V_{DS} = -100\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	-2	—	-4	V	$I_D = -250\mu\text{A}, V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 8)	$R_{DS(on)}$	—	—	0.35	Ω	$V_{GS} = -10\text{V}, I_D = -1.4\text{A}$
				0.45		$V_{GS} = -6\text{V}, I_D = -1.2\text{A}$
Forward Transconductance (Notes 8 & 9)	g_{fs}	—	2.8	—	S	$V_{DS} = -15\text{V}, I_D = -1.4\text{A}$
Diode Forward Voltage (Note 8)	V_{SD}	—	-0.85	-0.95	V	$I_S = -1.7\text{A}, V_{GS} = 0\text{V}$
Reverse Recovery Time (Note 9)	t_{rr}	—	33	—	ns	$I_S = -1.5\text{A}, di/dt = 100\text{A}/\mu\text{s}$
Reverse Recovery Charge (Note 9)	Q_{rr}	—	48	—	nC	
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	424	—	pF	$V_{DS} = -50\text{V}, V_{GS} = 0\text{V}$ $F = 1\text{MHz}$
Output Capacitance	C_{oss}	—	36.6	—	pF	
Reverse Transfer Capacitance	C_{rss}	—	29.8	—	pF	
Total Gate Charge (Note 10)	Q_g	—	7.1	—	nC	$V_{GS} = -6\text{V}$
Total Gate Charge (Note 10)	Q_g	—	10.7	—	nC	$V_{GS} = -10\text{V}$ $V_{DS} = -50\text{V}$ $I_D = -1.4\text{A}$
Gate-Source Charge (Note 10)	Q_{gs}	—	1.7	—	nC	
Gate-Drain Charge (Note 10)	Q_{gd}	—	3.8	—	nC	
Turn-On Delay Time (Note 10)	$t_{D(on)}$	—	3	—	ns	$V_{DD} = -50\text{V}, V_{GS} = -10\text{V}$ $I_D = -1\text{A}, R_G \approx 6\Omega$
Turn-On Rise Time (Note 10)	t_r	—	3.5	—	ns	
Turn-Off Delay Time (Note 10)	$t_{D(off)}$	—	13.4	—	ns	
Turn-Off Fall Time (Note 10)	t_f	—	7.2	—	ns	

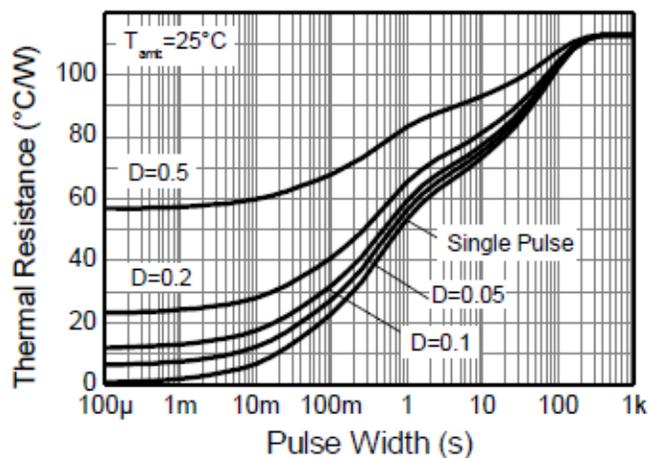
- Notes:
- For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
 - Same as Note 5, except the device is measured at $t \leq 5$ sec.
 - Same as Note 5, except the device is pulsed with $D = 0.05$ and pulse width 10 μs . The pulse current is limited by the maximum junction temperature.
 - Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
 - For design aid only, not subject to production testing.
 - Switching characteristics are independent of operating junction temperatures.



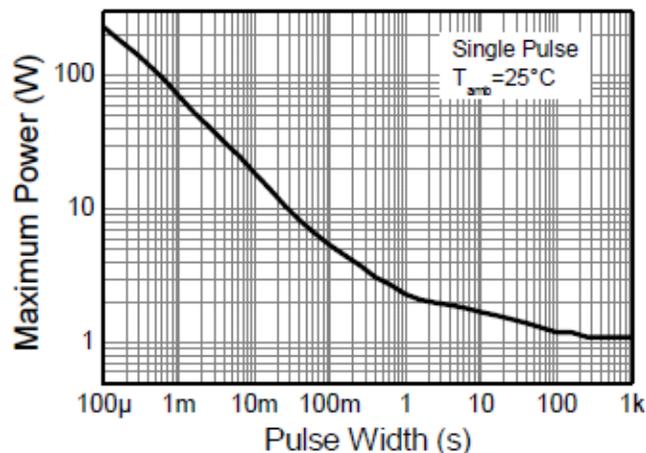
Safe Operating Area



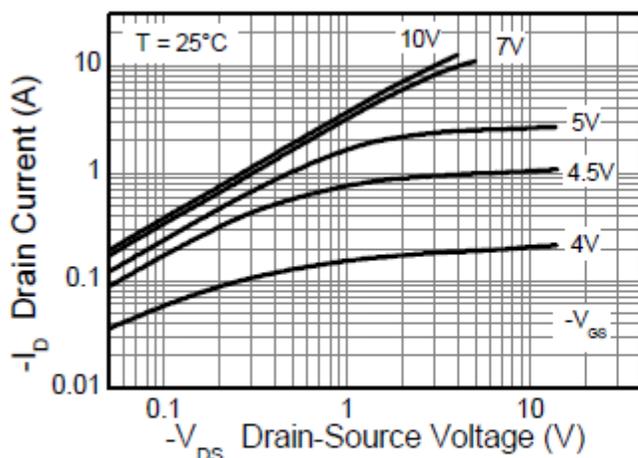
Derating Curve



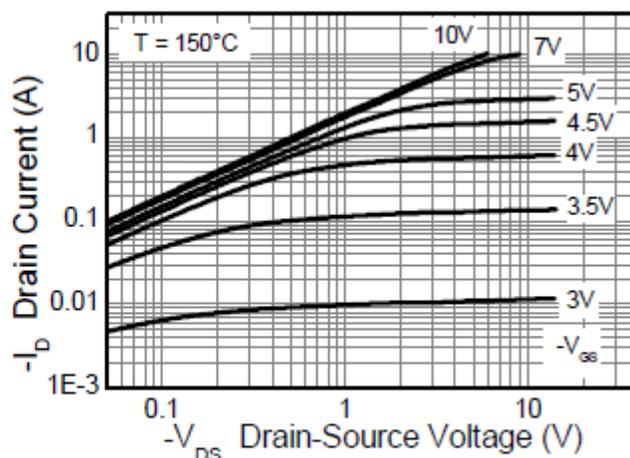
Transient Thermal Impedance



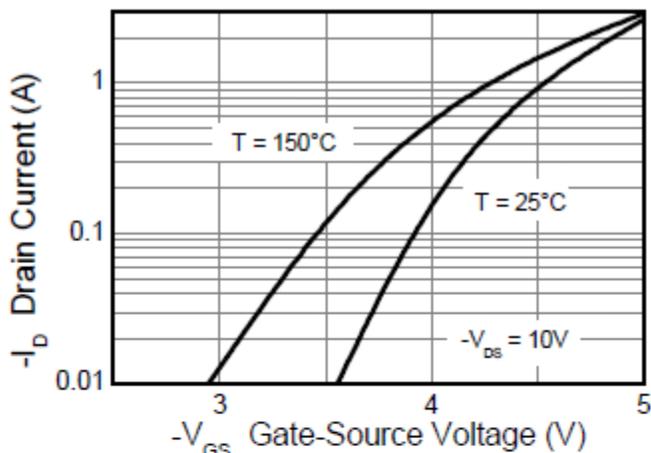
Pulse Power Dissipation



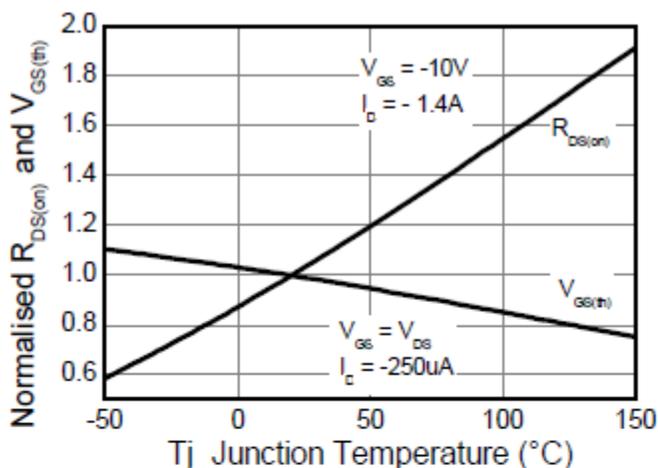
Output Characteristics



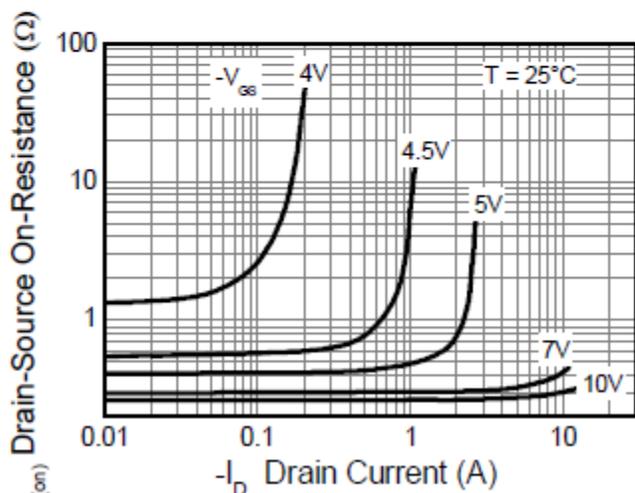
Output Characteristics



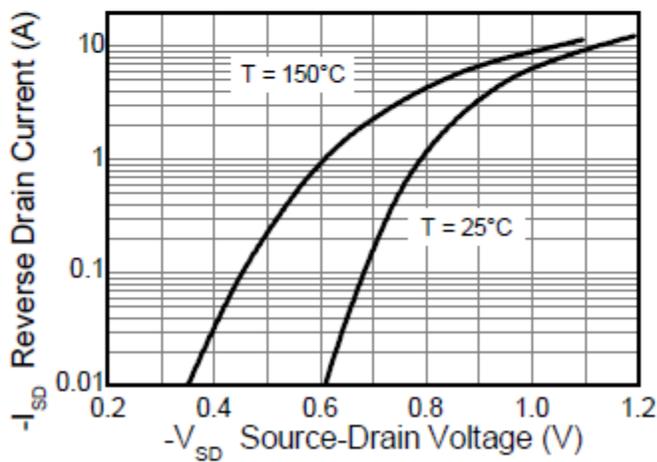
Typical Transfer Characteristics



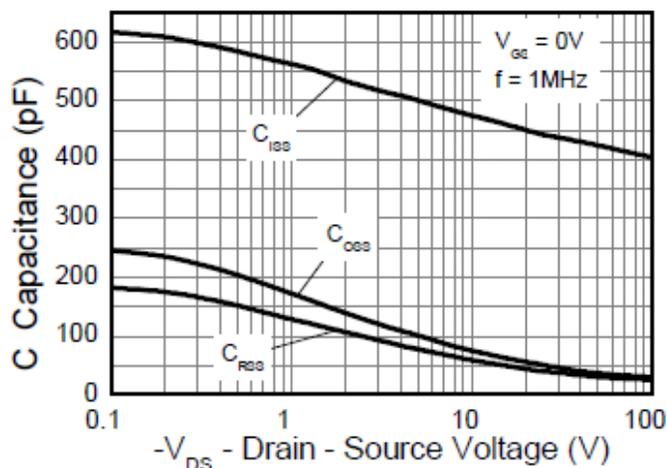
Normalised Curves v Temperature



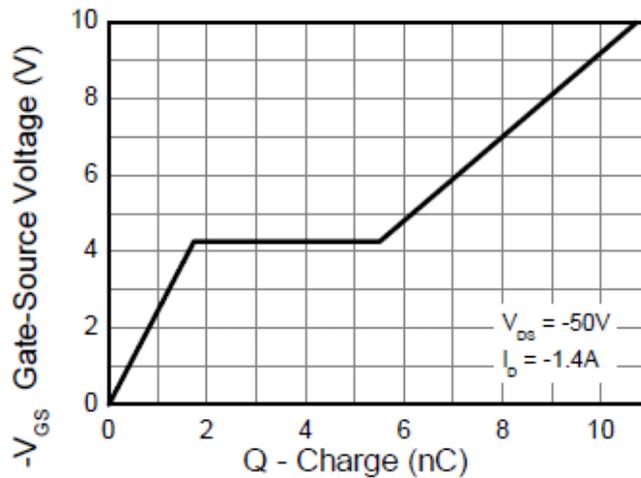
On-Resistance v Drain Current



Source-Drain Diode Forward Voltage

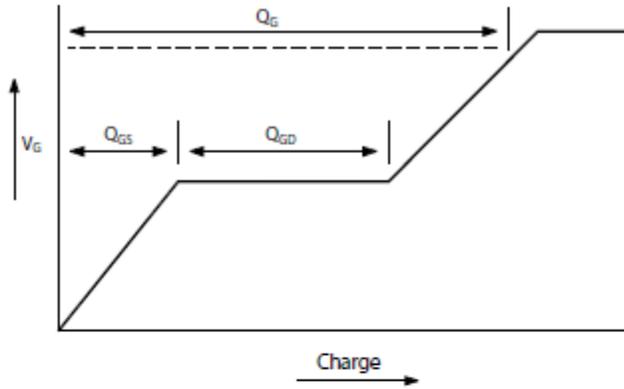


Capacitance v Drain-Source Voltage

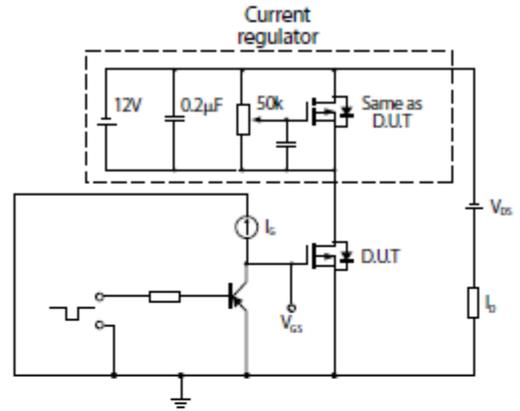


Gate-Source Voltage v Gate Charge

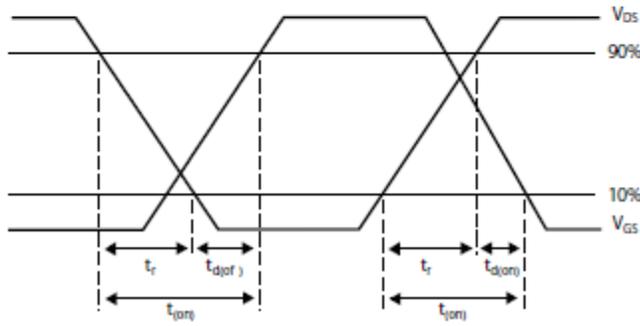
Test Circuits



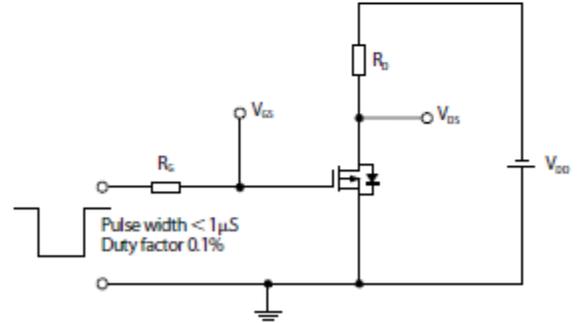
Basic gate charge waveform



Gate charge test circuit

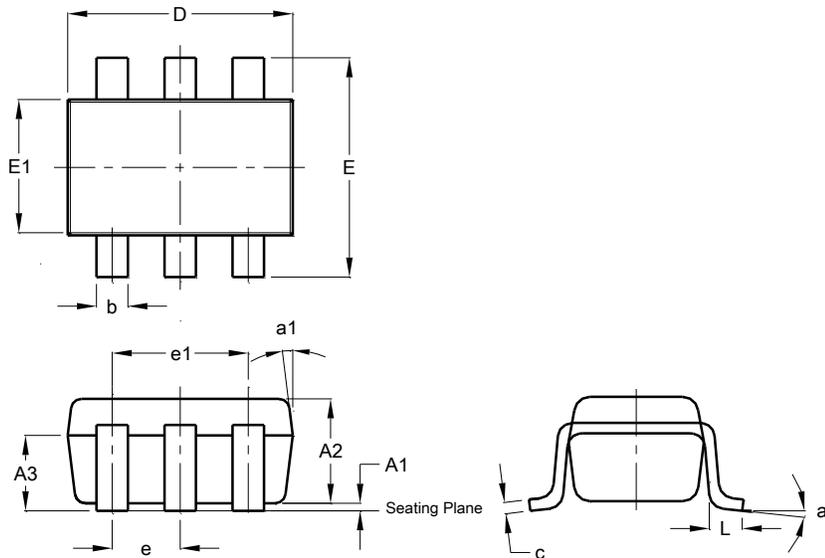


Switching time waveforms



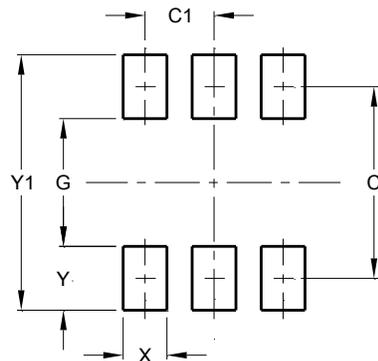
Switching time test circuit

Package Outline Dimensions



SOT26			
Dim	Min	Max	Typ
A1	0.013	0.10	0.05
A2	1.00	1.30	1.10
A3	0.70	0.80	0.75
b	0.35	0.50	0.38
c	0.10	0.20	0.15
D	2.90	3.10	3.00
e	-	-	0.95
e1	-	-	1.90
E	2.70	3.00	2.80
E1	1.50	1.70	1.60
L	0.35	0.55	0.40
a	-	-	8°
a1	-	-	7°
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
C	2.40
C1	0.95
G	1.60
X	0.55
Y	0.80
Y1	3.20